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IEEE JNL IEEE Journal or Magazine

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Domg, Y.; Milne, A.K.; forster, B.C.;  
[Geoscience and Remote Sensing, IEEE Transactions on](#)  
Volume 39, Issue 4, April 2001 Page(s):851 - 863  
Digital Object Identifier 10.1109/36.917910  
[AbstractPlus](#) | [References](#) | Full Text: [PDF](#)(376 KB) IEEE JNL  
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- ☐ 2. **Edge-shaped diamond field emission arrays**  
Takalkar, R.S.; Davidson, J.L.; Kang, W.P.; Wisitsora-at, A.; Kerns, D.V.;  
[Vacuum Nanoelectronics Conference, 2004. IVNC 2004. Technical Digest of the](#)  
[International](#)  
11-16 July 2004 Page(s):156 - 157  
Digital Object Identifier 10.1109/IVNC.2004.1354947  
[AbstractPlus](#) | Full Text: [PDF](#)(242 KB) IEEE CNF  
[Rights and Permissions](#)
- ☐ 3. **Fingerprint enhancement based on edge-directed diffusion**  
Xie Meihua; Wang Zhengming;  
[Image and Graphics, 2004. Proceedings. Third International Conference on](#)  
18-20 Dec. 2004 Page(s):274 - 277  
Digital Object Identifier 10.1109/ICIG.2004.68  
[AbstractPlus](#) | Full Text: [PDF](#)(696 KB) IEEE CNF  
[Rights and Permissions](#)
- ☐ 4. **Perceptual impact of edge sharpness in images**  
Lin, W.S.; Gai, Y.L.; Kassim, A.A.;  
[Vision, Image and Signal Processing, IEE Proceedings-](#)  
Volume 153, Issue 2, 6 April 2006 Page(s):215 - 223  
Digital Object Identifier 10.1049/ip-vis:20050110  
[AbstractPlus](#) | Full Text: [PDF](#)(1359 KB) IEE JNL
- ☐ 5. **A nonlinear PDE based edge detection for image measurement**  
Shujun Fu; Qiuqi Ruan; Wenqia Wang;  
[Control and Automation, 2005. ICCA '05. International Conference on](#)  
Volume 2, 26-29 June 2005 Page(s):1028 - 1033 Vol. 2  
Digital Object Identifier 10.1109/ICCA.2005.1528273